

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**IN RE APPLICATION: **DELATTRE, Cyril, et al**

GROUP ART UNIT: TBA

SERIAL NUMBER: 10/576,342

EXAMINER: TBA

FILED: April 18, 2006

FOR: **PROCESS FOR DISTRIBUTING DROPS OF A LIQUID OF INTEREST ONTO A SURFACE****INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.97**

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Applicant(s) wish to disclose the following information.

**REFERENCES**

- The Applicant(s) wish to make of record the references listed on the attached PTO/ SB/08. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check is attached in the amount required under 37 CFR § 1.17(p).

**RELATED CASES**

- Attached is a list of applicant's pending applications or issued patents which may be related to the present application. A copy of the patent(s) is attached along with PTO/ SB/08.
- A check is attached in the amount required under 37 CFR § 1.17(p).

**CERTIFICATION**

The undersigned certifies that

- each item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- no item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR § 1.56(c) more than three months prior to the filing of this statement.

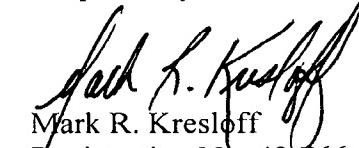
PETITION

Applicant(s) hereby request consideration of the attached information. A check is attached in the amount of the Petition fee required under 37 CFR § 1.17(i)(1).

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account No. 50-0911. A duplicate copy of this sheet is enclosed.

Respectfully submitted,



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Date: December 28, 2006

PTO/SB/08a/b (05-03)

Approved for use through 05/31/2003. OMB 0651-0031

U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

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Substitute for form 1449/PTO				<i>Complete if Known</i>	
				Application Number	10/576,342
				Filing Date	April 18, 2006
				First Named Inventor	DELATTRE, Cyril
				Art Unit	TBA
				Examiner Name	TBA
Sheet	1	of	2	Attorney Docket Number	10404.038.00-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
AA		6,143,496 •	11-07-2000	BROWN, ET AL.	
AB		6,210,894 B1 •	04-03-2001	BRENNAN	
AC		6,565,813 B1 •	05-20-2003	GARYANTES	
AD		6,040,193 •	03-21-2000	FODOR, ET AL.	
AE					
AF					

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
BA		WO 02/41992 A2 •	05-30-2002	SIEMENS AKTIENGESELLSCHAFT	
BB		WO 03/059518 A1 •	07-24-2003	UNIVERSITY COLLEGE CORK-NATIONAL UNIVERSITY OF IRELAND, CORK	
BC		WO 02/16023 A2 •	02-28-2002	PROTO-GENE LABORATORIES, INC.	
BD		WO 99/03684 •	01-28-1999	CAMBRIDGE SENSORS LIMITED	
BE		WO 00/36145 (w/Abstract) •	06-22-2000	COMMISSARIAT ENERGIE ATOMIQUE	
BF		WO 02/090573 A2 (w/Abstract)	11-14-2002	INFINEON TECHNOLOGIES AG	
BG		FR 2 818 662 A1	12-22-2000	COMMISSARIAT A L'ENERGIE ATOMIQUE	
BH		EP 0 561 722 A1	03-17-1993	BIO MERIEUX	
BI					
BJ					

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Ann Lam/	Date Considered	10/01/2008
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DC:50452825.1

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.L./

PTO/SB/08a/b (05-03)

Approved for use through 05/31/2003. OMB 0651-0031

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>				Application Number	10/576,342
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Sheet	2	of	2	Attorney Docket Number	
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## **U.S. PATENT DOCUMENTS**

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		Number-Kind Code <sup>2</sup> (if known)			

## FOREIGN PATENT DOCUMENTS

## **NON PATENT LITERATURE DOCUMENTS**

Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	CA	Azek, F., et al., Hybridization Assay at a Disposable Electrochemical Biosensor for the Attomole Detection of Amplified Human Cytomegalovirus DNA, <i>Analytical Biochemistry</i> 284, 2000, pp. 107-113	
	CB	Lee, J., et al., Electrowetting and electrowetting-on-dielectric for microscale liquid handling, <i>Sensors and Actuators A</i> 95, 2002, pp. 259-268	
	CC	Bratton, C.D., et al., Micromachining Sensors for Electrochemical Measurement in Subnanoliter Volumes, <i>Analytical Chemistry</i> , Vol. 69, No. 2, 1997, pp. 253-258	
	CD	Yang, M., et al., Covalent Immobilization of Oligonucleotides on Modified Glass/Silicon Surfaces for Solid-phase DNA Hybridization and Amplification, <i>The Chemical Society of Japan</i> , 1998, pp. 257-258	
	CE	Boncheva, M., et al., Design of Oligonucleotide Arrays at Interfaces; <i>American Chemical Society</i> , 1999 pp. 4317-4320	
	CF	Jansen, H., et al., The black silicon method: a universal method for determining the parameter setting of a fluorine-based reactive ion etcher in deep silicon trench etching with profile control, <i>J. Micromech. Microeng.</i> 5, 1995, pp. 115-120	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Ann Lam/	Date Considered	10/01/2008
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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.L./